Carbon Nanotube Electronics

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Nanoelectronics FFF160

Outline

• Basics of graphene and CNTs

- Structural
- Electronic
- Production of CNTs

• Advantages of CNTs for FETs

- Electrostatics -> length scaling
- High-k compatibility
- Band-to-band tunneling

• Challenges of CNT integration

- Contacts
- Doping
- Positioning
- Chirality control

Towards integration

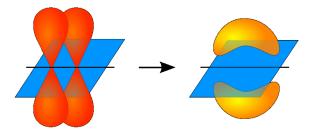
- Flexible electronics
- High frequency performance

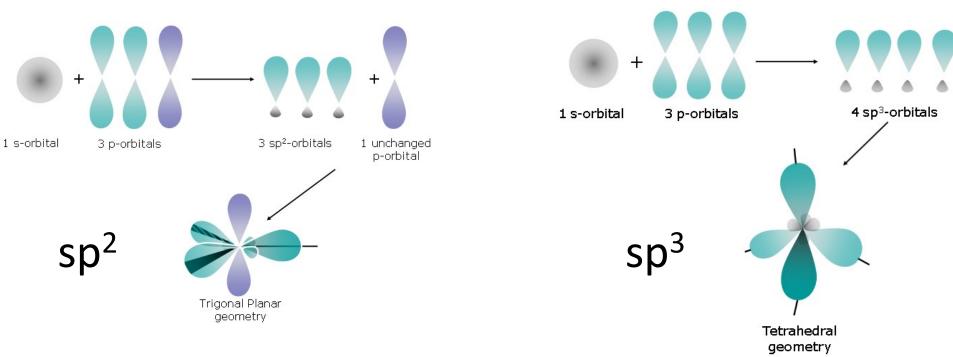
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Hybridisation of carbon orbitals

- 4 valence electrons
- 1 s-electron can "mix" with 1-3 p-electrons
- sp^2 have three σ -bonds in a plane + π -bond
- sp^3 have four σ -bonds





Carbon allotropes

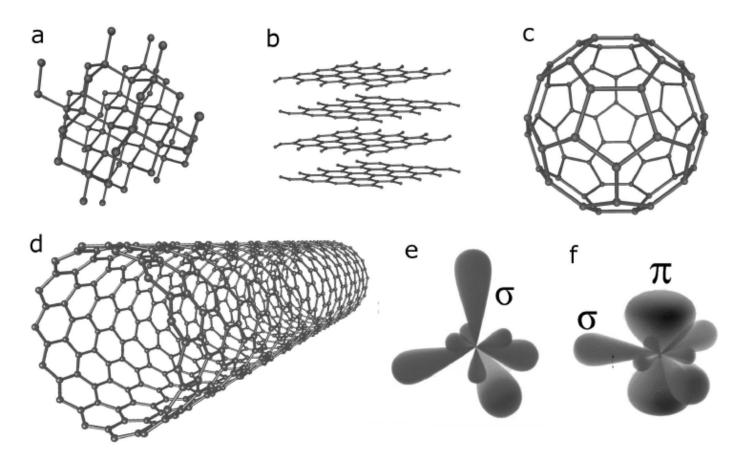
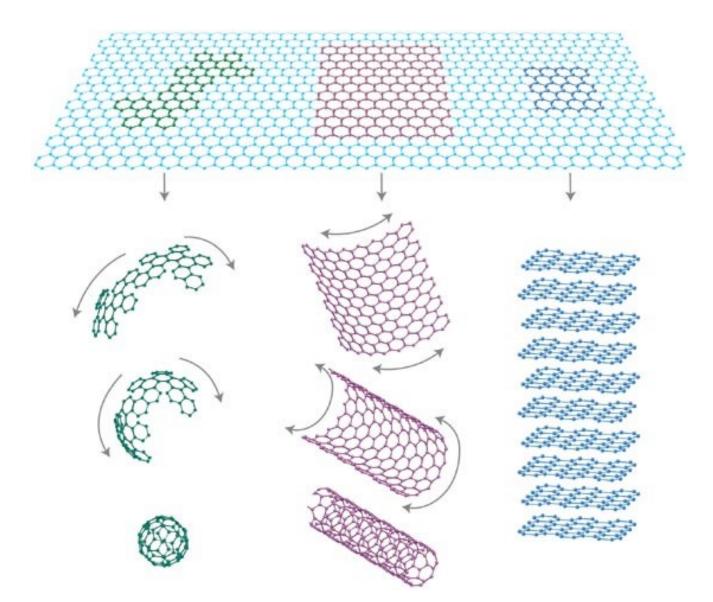


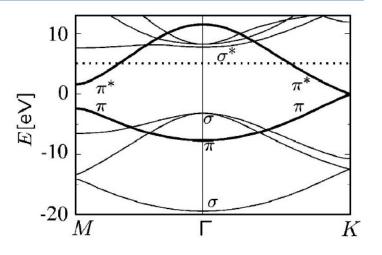
Figure 2.1: a-d) Crystal structure of a few carbon allotropes a) Diamond b) Graphite c) C_{60} d) CNT. e) sp^3 hybridised orbitals forming σ bonds. f) sp^2 hybridised orbitals forming σ bonds and the remaining p_z orbital giving rise to π bonds.

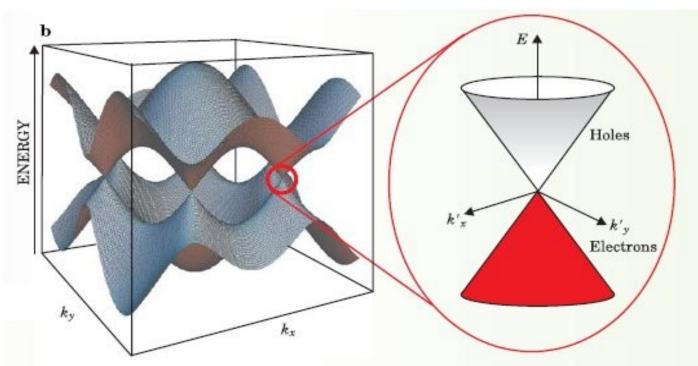
Graphene is mother of all sp²-carbon



Graphene band structure

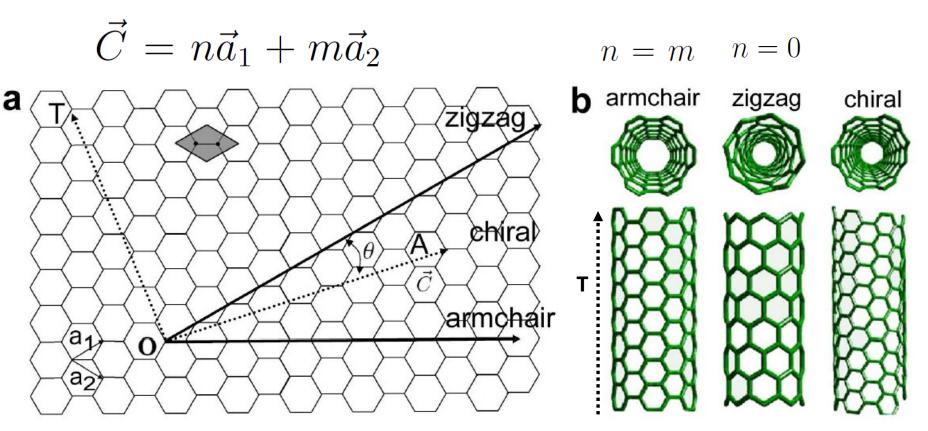
- Semimetal: no gap and zero DOS at E_f
- Only π-bands are interesting
- Linear dispersion near E_f
- Conduction and valence bands meet at the K-points





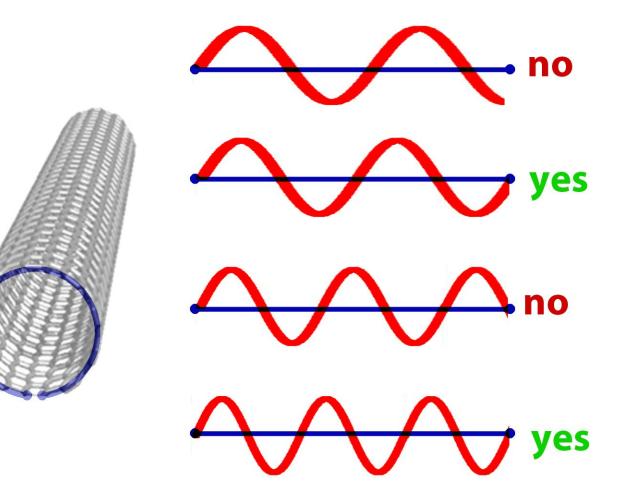
Rolling graphene

- Cut graphene into narrow strip and roll into tube
- Different structure depending on direction of cut
- Armchair, zigzag, chiral CNTs
- Chirality defined by index (n,m)



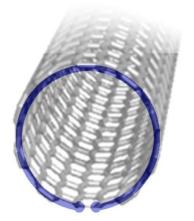
Confinement of electron wavefunctions

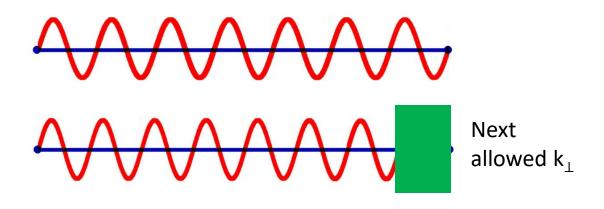
- Have to have continous wavefunction around circumference
- Periodic boundary conditions
- Only some wavevectors k_{\perp} = 2n π /C with n=1,2,3... allowed



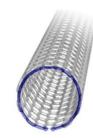
Diameter dependence of confinement

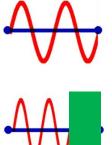
large diameter = small energy difference





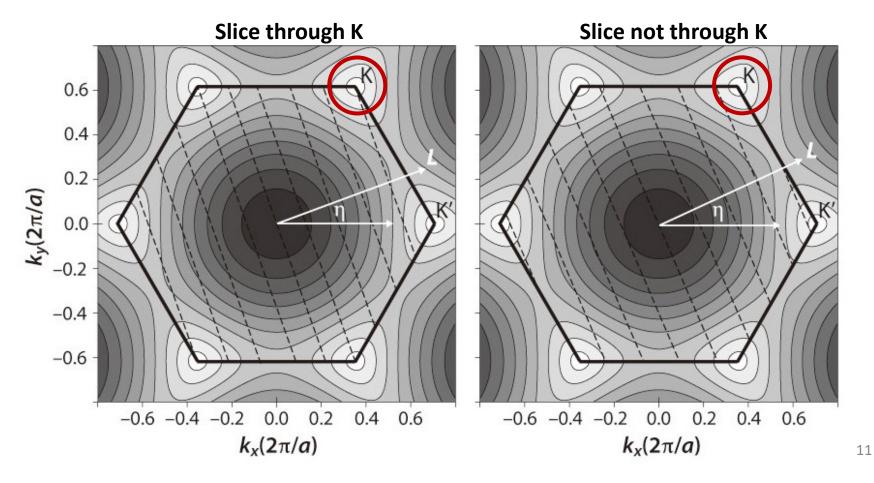
small diameter = large energy difference





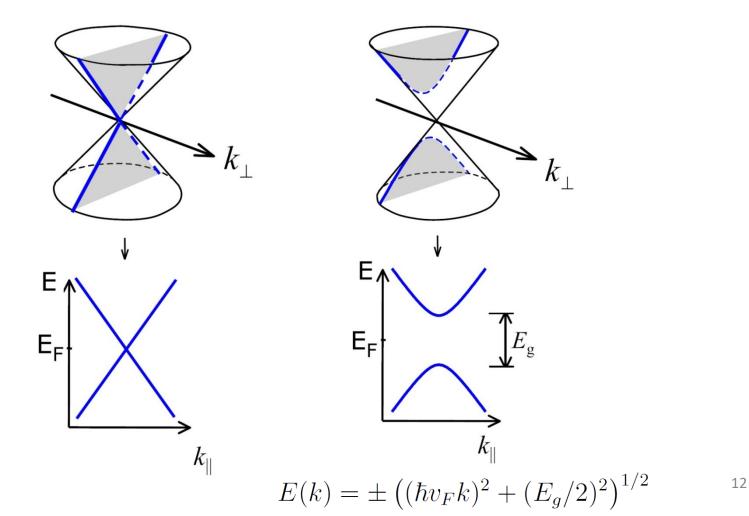
Confinement of electron wavefunctions

- Slices in graphene dispersion relation of allowed wavevectors around circumference
- Position of slices depends on chirality
- Small diameter CNT have larger distance between slices



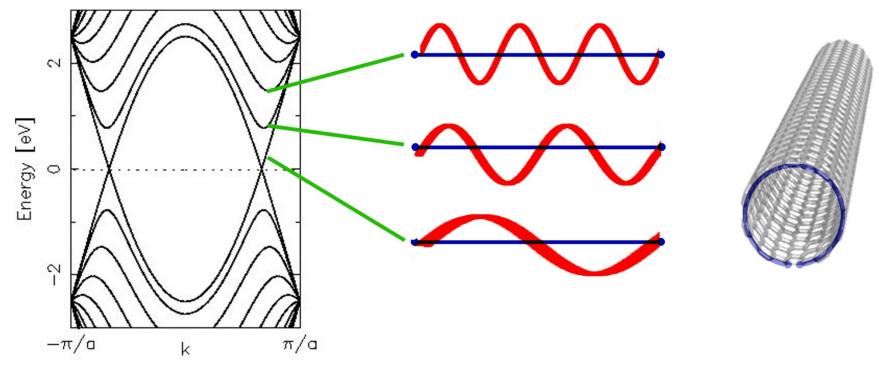
Allowed wavevectors

- n-m = 3i with i=1,2,3... -> slice goes through K-point -> metallic CNT
- n-m ≠ 3i -> slice does not go through K-point -> semiconducting CNT with parabolic bands



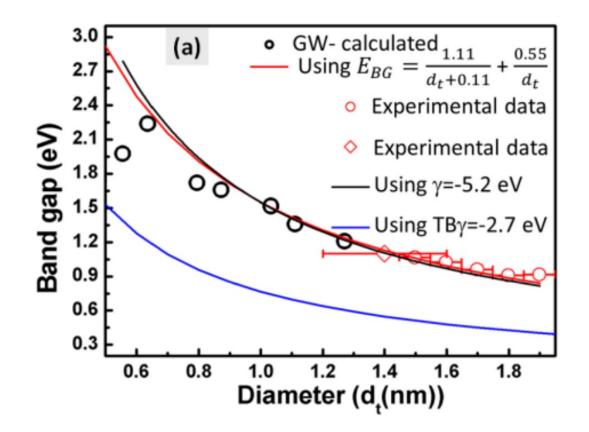
Subbands

- π -bands split into 1D subbands of increasing energy
- Mainly important at high gate voltages or for optical transistions
- Wavefunctions just schematic, need TB calculation



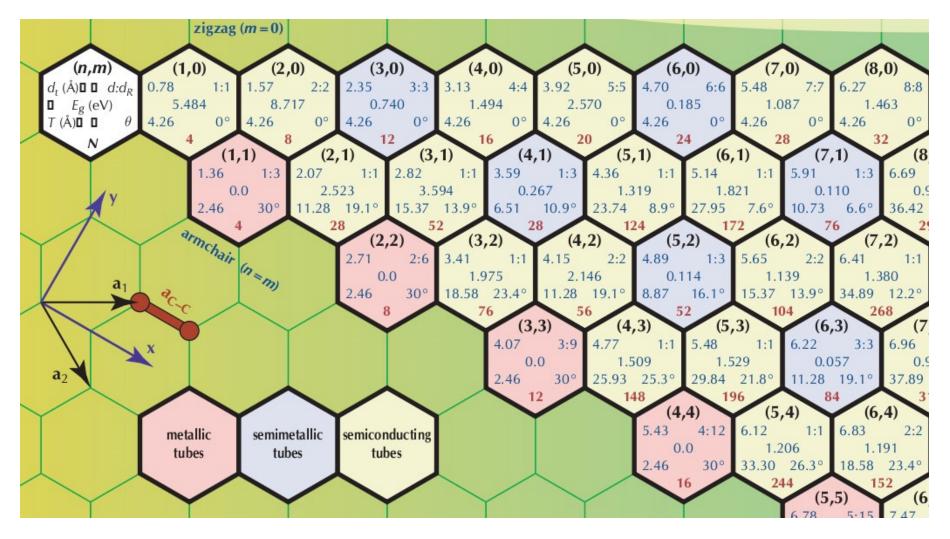
Band gap vs diameter

- Linear dispersion of graphene gives E_g inversely proportional to diameter for CNTs
- Curvature induced gap of 10's of meV in most of the "metallic" CNTs
- Only armchair CNTs truly metallic



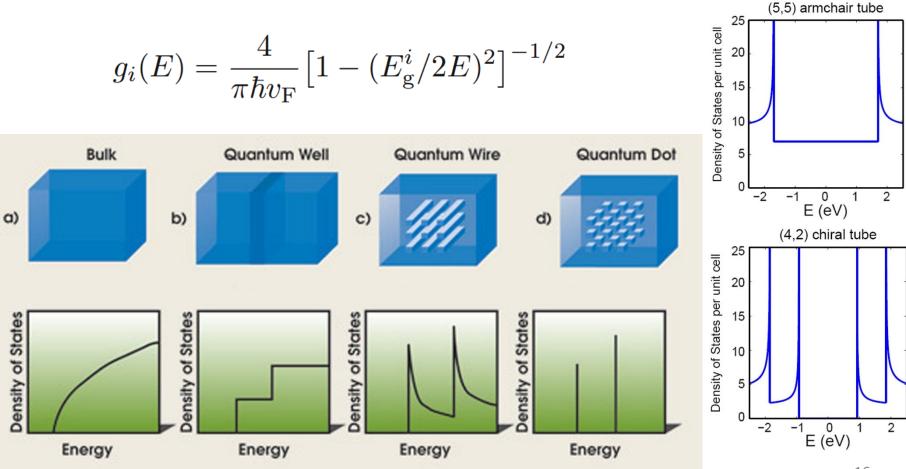
All CNTs are different

- 1/3 metallic or small gap
- 2/3 semiconducting with different gap



Density of states

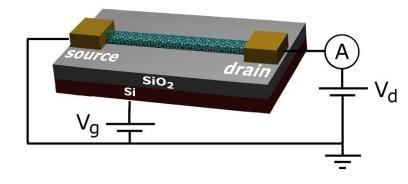
- Van Hove singularites with high DOS at band edges
- Can be seen in scanning tunneling microsope or capacitance measurements
- Strong influence on optical properties

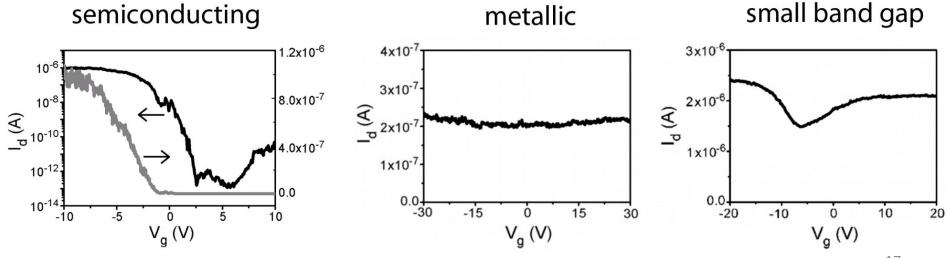


Electrical characteristics

- Three types
 - 1. Semiconducting: strong gating effect
 - 2. Metallic: no gating effect
 - 3. Small gap semiconducting: some gating effect

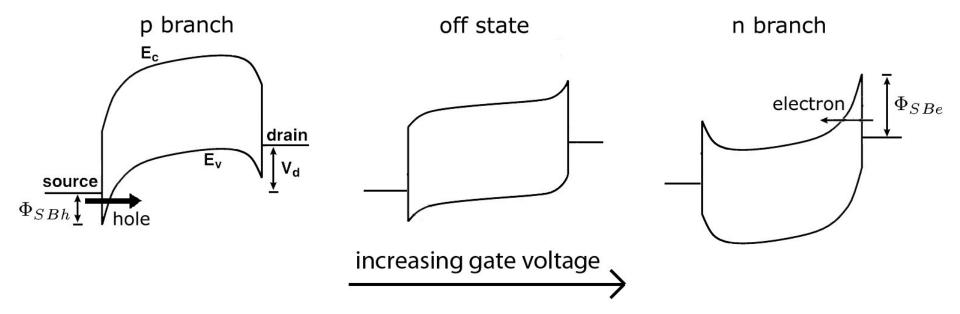






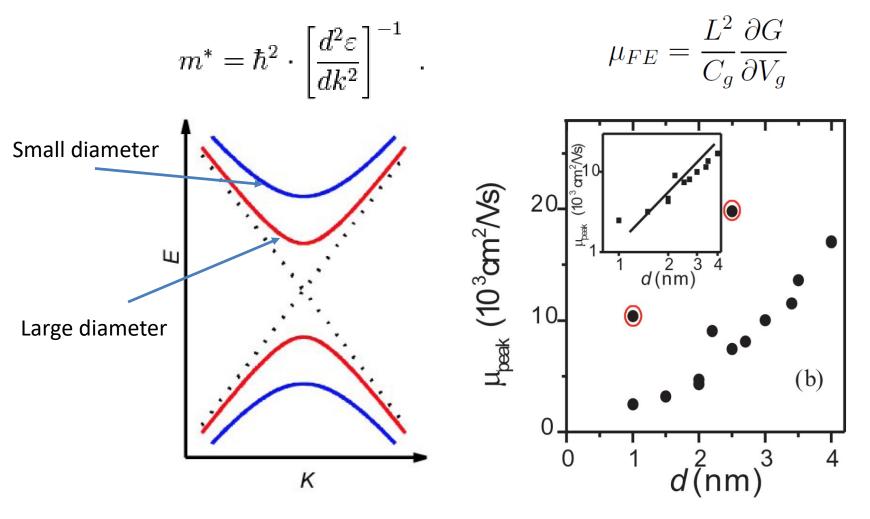
Transport through Schottky barriers

- First CNTFETs had Schottky barriers at metal contacts
- Tunneling through SB determines transport
- Negative gate voltages -> hole transport
- Positive gate voltages -> electron transport
- Similar SB heights -> ambipolar characteristics



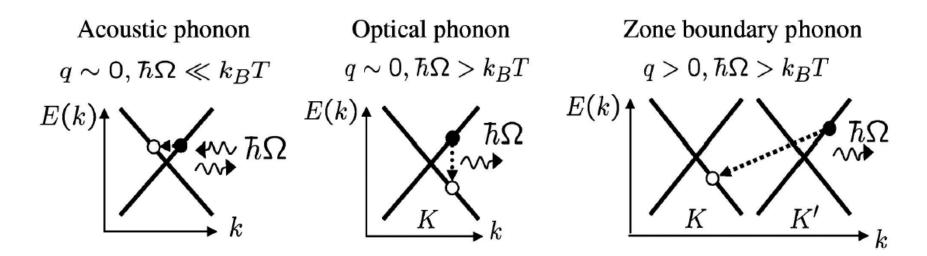
Mobility vs diameter

- Lower curvature of bands for smaller diameter -> mobility proportional to d²
- $\mu > 100\ 000\ cm^2/Vs$ at 50 K



Scattering

- Elastic scattering have to reverse direction of electron
- Acoustic phonon scattering dominates at low bias and gives mfp > 300 nm
 -> ballistic transport possible
- Optical phonons scattering dominates at high bias and gives mfp = 15 nm
- Potential variations or phonons in substrate under CNT can also scatter electrons

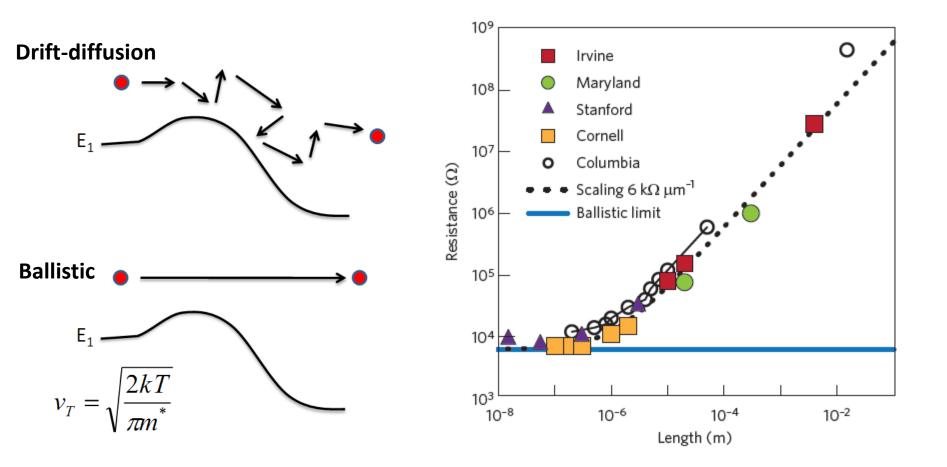


1D

3D

Ballistic transport

- Channel length << mfp -> no scattering in channel
- Mobility not relevant but injection velocity is
- $R_{min} = h/4e^2 = 6.5$ kOhm in ballistic 1D system with 4 modes



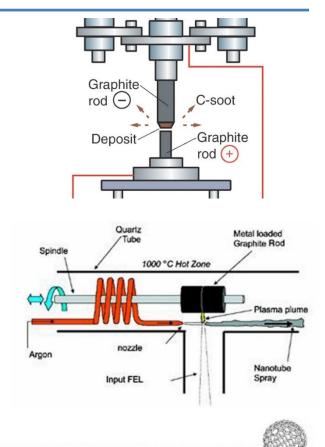
Production of CNTs

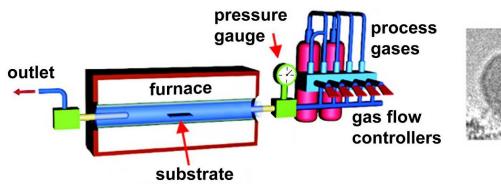
0.20 nm

 Arc discharge: high voltage creates spark between graphite rods

• Laser ablation: laser vaporises graphite target

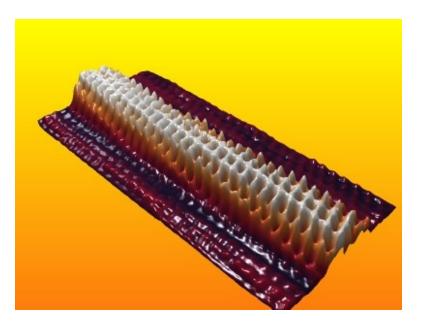
• Chemical vapor deposition: metal catalyst particles decompose hydrocarbon gas

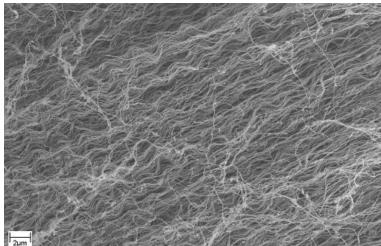


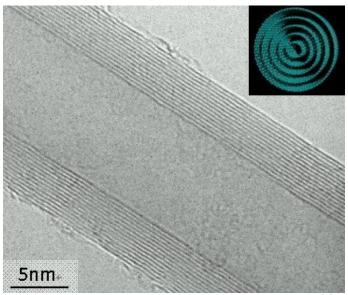


Grown CNTs

- d=1-4 nm, L > 30 cm
- Can be imaged using SEM, TEM, AFM, STM
- Deposit from suspension or grow on device substrate
- Mix of metallic, semiconducting and small band gap semiconducting







VANTA black

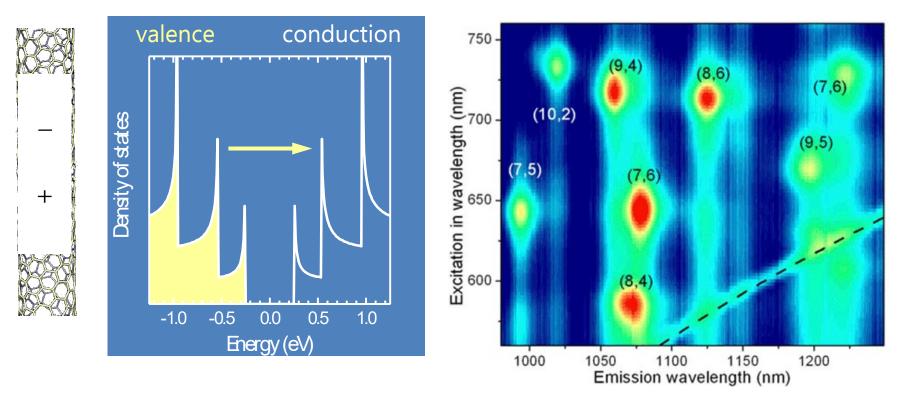
- Vertically Aligned NanoTube Array
- Absorbs 99.965% of visible light





Determination of type

- Photoluminescence with varying excitation $\boldsymbol{\lambda}$
- Every (n,m) nanotube has specific pairs of transition energy



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Gate length scaling

+ Increased speed \rightarrow lower gate delay (CV/I), higher transconductance (g_m) and therefore cut-off frequency (f_T)

- + Reduced power consumption -> energy delay product (CV/I \cdot CV²)
- + Enables higher packing density -> less interconnect delay, cheaper

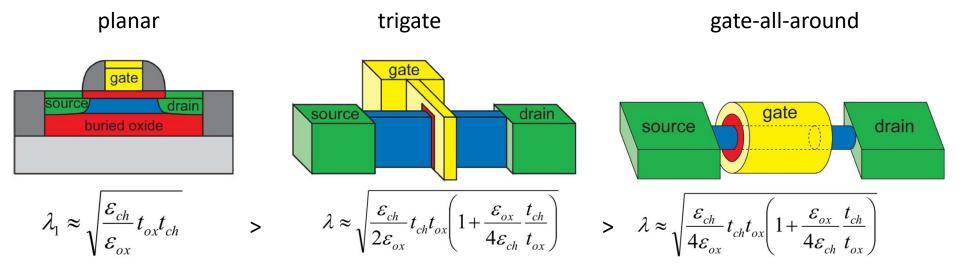
- Short channel effects (e.g. poor SS, DIBL, high output conductance (g_d)) when drain influence potential in the channel.

ITRS 2015 - 3 nm node: L_g =10 nm, L_c =11 nm, spacer=4 nm -> footprint =40 nm

Need to reduce gate dielectric thickness, increase dielectric constant or change geometry.

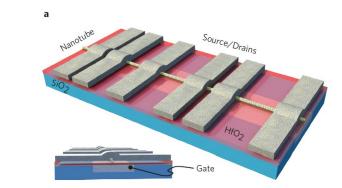
Different gate geometries

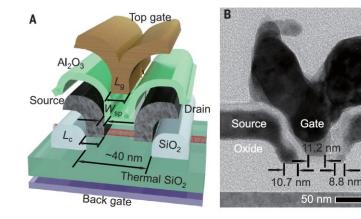
- λ = screening length, reduced by higher gate dielectric constant or thinner channel
- $L_g > 5 \lambda$ to avoid short channel effects
- More "wrapping" of the channel reduces $\lambda \rightarrow \text{enables } L_g$ scaling
- CNTs and graphene allows for very good gate length scaling



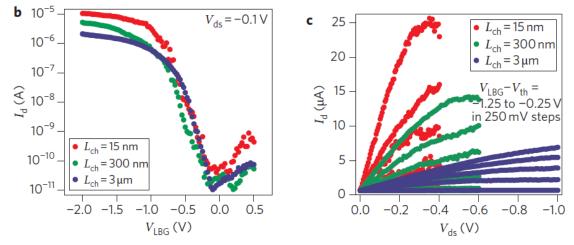
Gate length scaling

- No short channel effects (DIBL, SS degradation) down to L_g=15 nm
- $I_{on} = 0.9 \text{ mA/}\mu\text{m}$ -> normalisation ?
- on/off ratio = 10^5
- SS = 90 mV/dec also for short devices





Drain

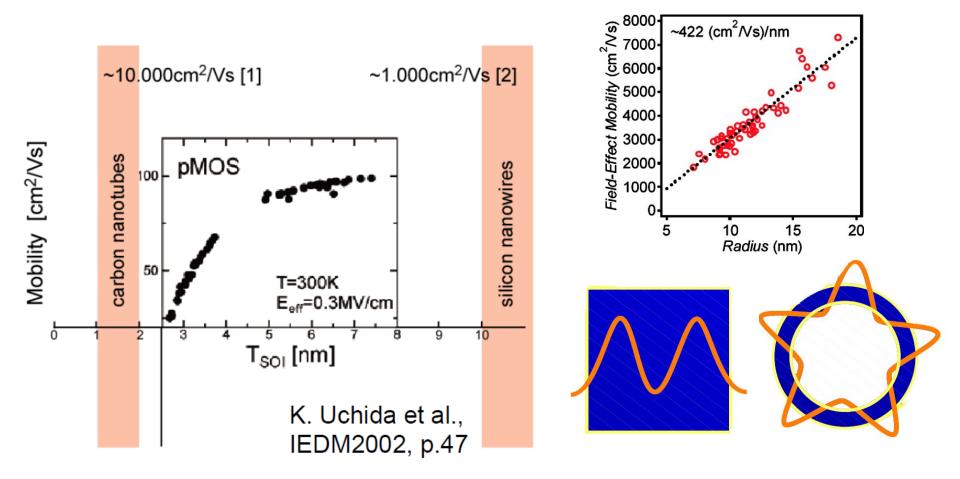


Franklin et al. Nature Nanotechnol. 5, 858-862 (2010)

Cao et al., *Science* 356, 1369–1372 (2017)

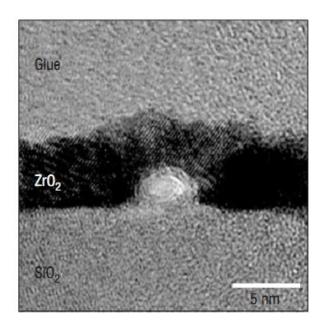
Surface scattering

- Need to reduce channel thickness to be able to reduce L_g
- Surface scattering and roughness gives $\mu \sim 1/t^6$ for SOI MOSFETs
- Not a problem for CNTs no unsaturated bonds / no roughness

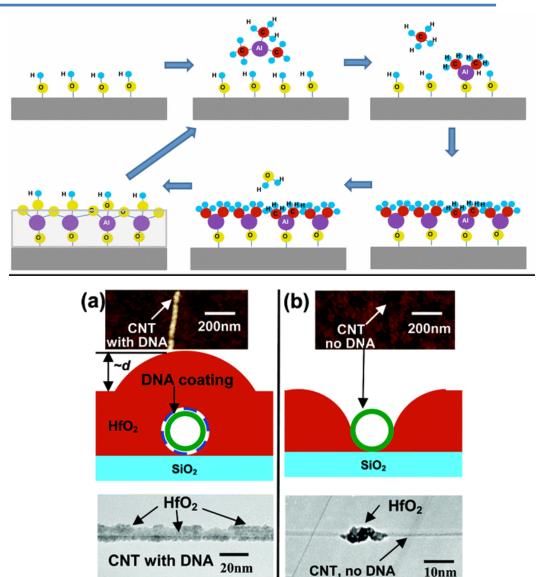


High k gate dielectrics

- Need OH groups for ALD.
- Overgrow from surface or functionalize CNT.
- No dangling bonds give nice interface? Traps in oxide?



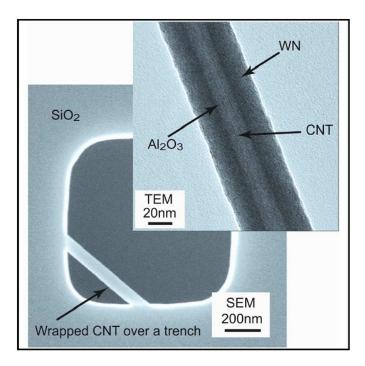
Javey et al. *Nature Materials*, 1 (4), 241-246, 2002

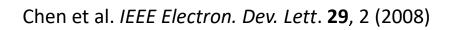


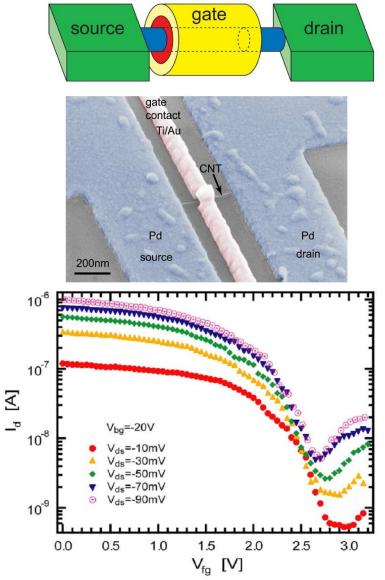
Lu et al. J. Am. Chem. Soc., 128, 3518–3519, 2006

Gate-all-around CNTFET

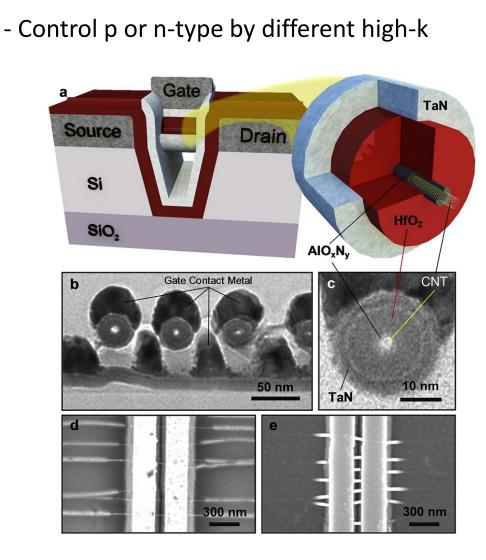
- Wrap CNT in Al2O3 and WN using ALD
- Poor subthreshold swing due to interface traps and short channel effects

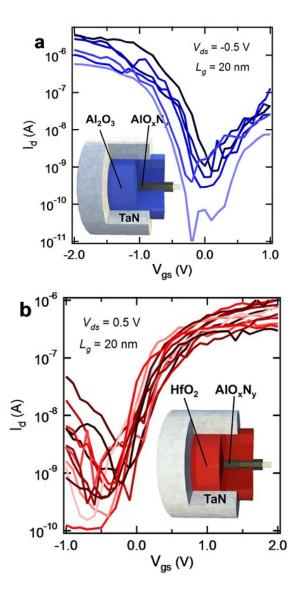






Different high-k



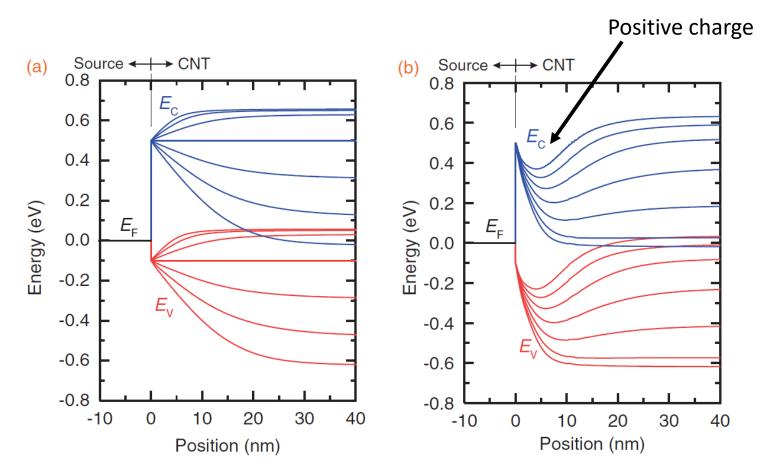


Franklin et al. *Nano Lett.* 13 (6), (2013)

Conversion from p- to n-type

- High work function metal -> low Schottky barrier to valence band

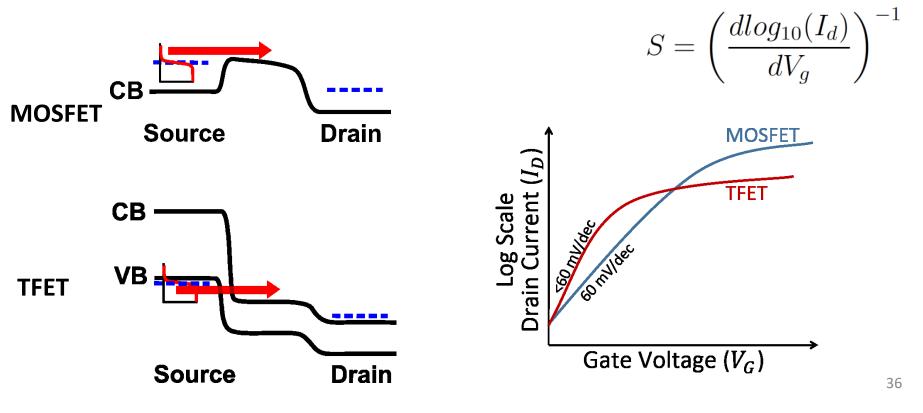
- Positive charge (in e.g. oxide) close to contact increases barrier to valence band and thins down barrier to conduction band.



Suzuki, Appl. Phys. Express 6 (2013)

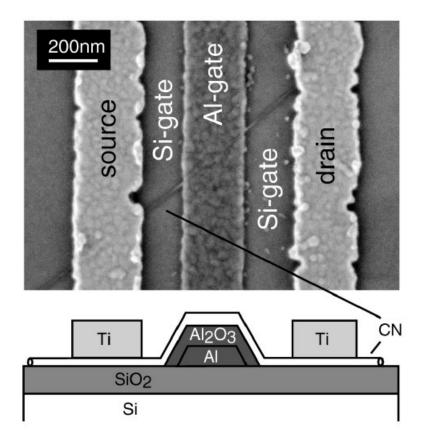
Improving the inverse subthreshold slope

- "conventional" FETs rely on thermionic emission over a barrier
- SS \ge ln(10) k_BT = 60 mV/dec at room temperature
- A decreased SS enables a lower V_{dd} while keeping the same on/off ratio -> increased speed and reduced power consumption



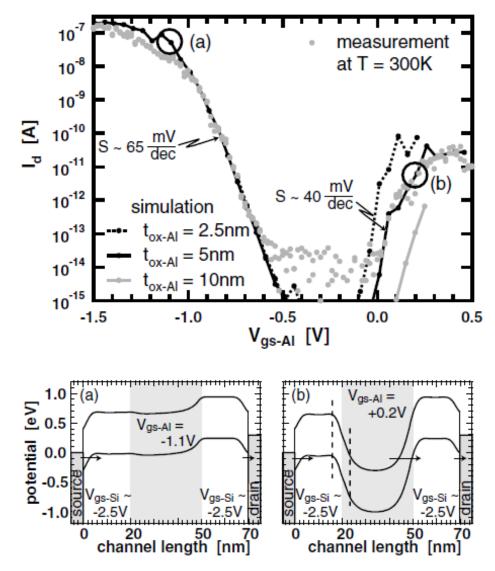
Band-to-band tunneling transistor

- λ is a few nm in CNT > sharp band bending
- Low effective mass
- Long mfp
- Same effective mass of electrons and holes
- Direct band gap



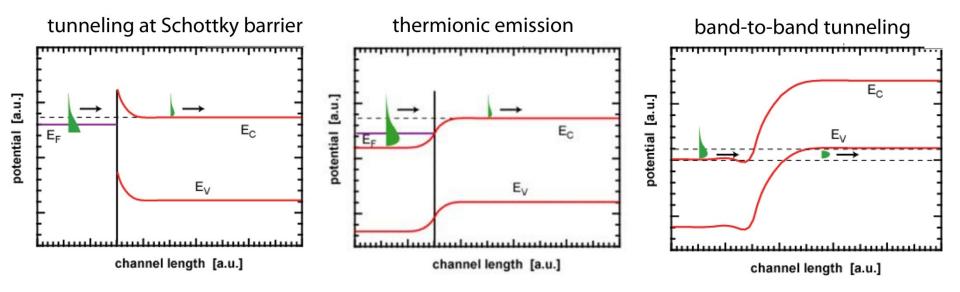
Electrical characteristics

- Back gate to form p-type regions
- Al gate to switch FET
- Ambipolar characteristics
- SS=40 mV/dec for the n-branch
- Band-to-band tunneling at the border between the gates



Mechanism of SS reduction

- Only high energy tail of Fermi-Dirac distribution is transferred in thermionic emission or in tunneling through Schottky barrier
- Band-to-band tunneling "filters" the Fermi-Dirac distribution
- For BTB tunneling, small movement of bands give large change in current i.e. small SS



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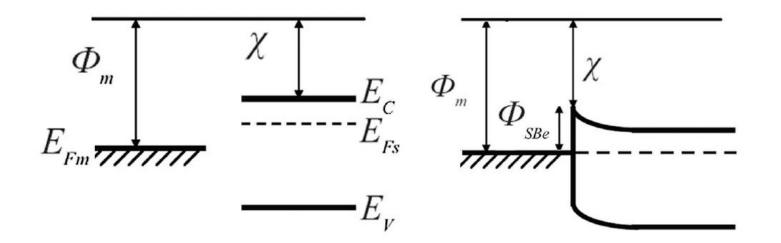
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Schottky barrier basics

- Potential barrier between metal and semiconductor
- Gives rectifying behaviour
- Change metal work function -> change SB height
- Too simple !!!

$$\Phi_{SBe} = \phi_m - \chi$$

$$\Phi_{SBh} = \chi + E_g - \phi_m = I_s - \Phi_m$$

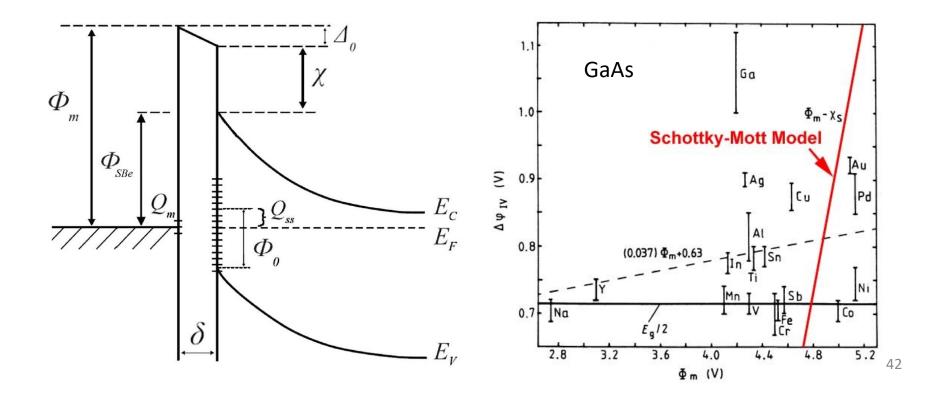


Fermi level pinning

- Interface states form dipoles that shift bands
- SB height often independent on metal work function

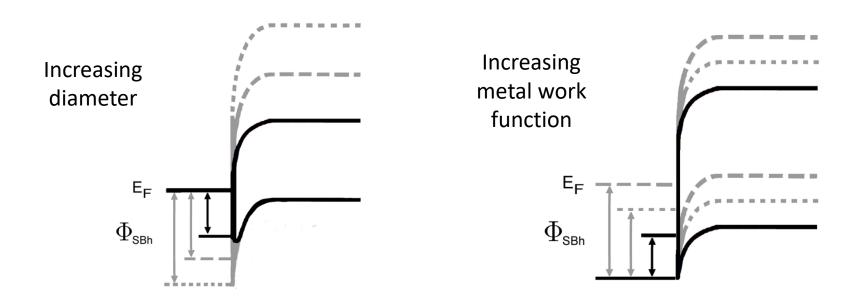
$$\Phi_{SBe} = \gamma (\Phi_m - \chi) + (1 - \gamma)(E_g - \Phi_0) \qquad \gamma = \frac{1}{1 + \frac{qD_{it}\delta}{\epsilon_i}}$$

-1



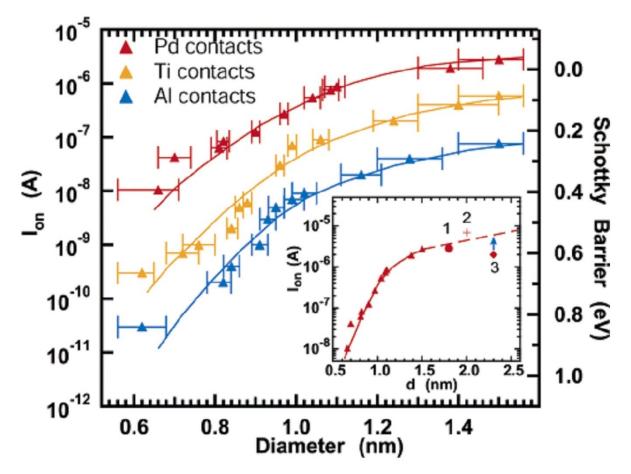
Schottky barrier to CNTs

- Theoretically predicted that interface states have no influence on CNT-metal contacts
- Increasing CNT diameter gives lower barriers
- Increasing metal work function gives lower hole barriers

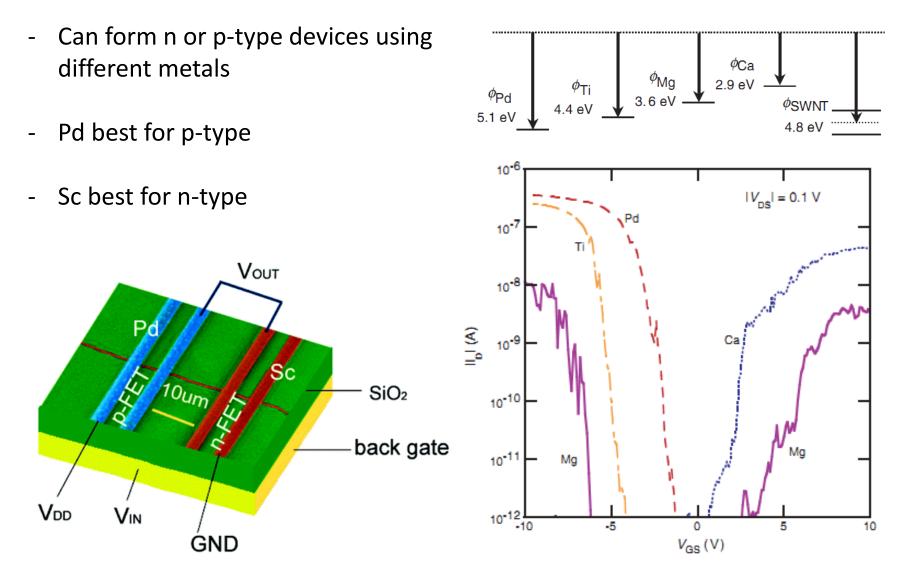


Different contact metals

- Increasing I_{on} with larger CNT diameter
- Increasing I_{on} with higher work function
- No or small effect of Fermi level pinning



Impact of metal work function

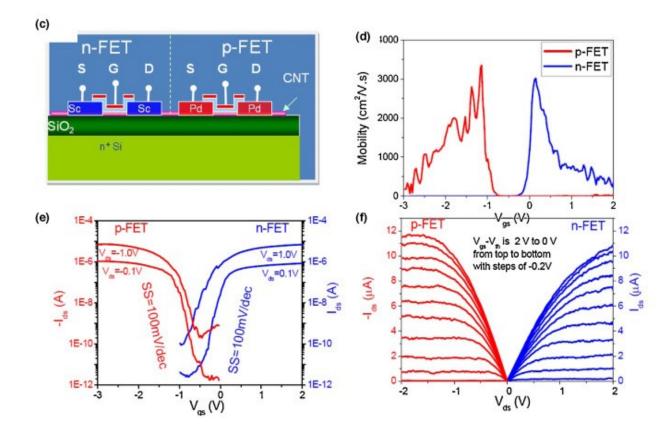


Nosho et al. Nanotechnology 17, 3412 (2006)

CNTFETs for CMOS

- For most semiconductors $\mu_e > \mu_h$

 Symmetric valence and conduction bands give similar P and NMOS performance for CNTFETs



gap

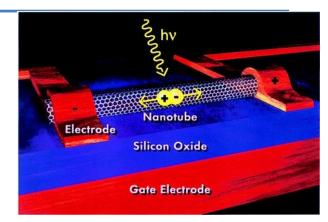
 k_{\parallel}

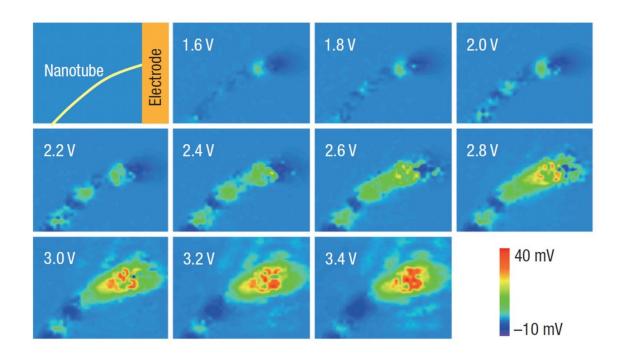
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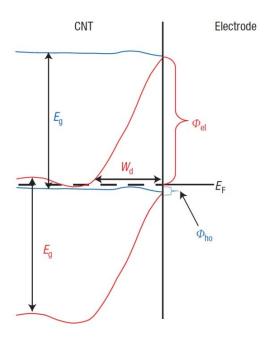
 k_{\perp}

Imaging Schottky barriers

- Laser generates e-h pairs
- Pair separated by electric field -> photocurrent
- Scan laser spot and change gate voltage
- Obtains size of depletion width



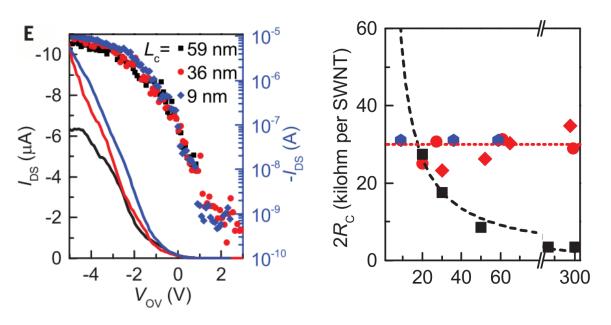


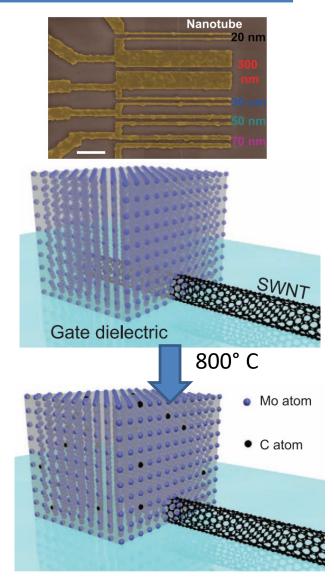


Freitag et al. Nano Lett. 7, 2037–2042 (2007)

End bonded contacts

- Mo contacts heated to 800°C forms Mo₂C
- Sidecontact transformed to end contact
- Contact only 2 nm²
- Useful for very dense circuits



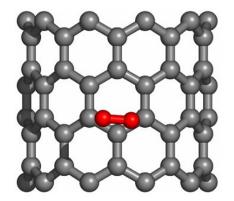


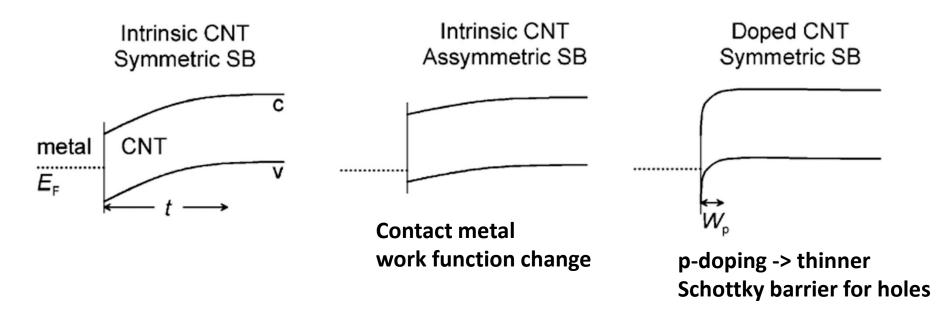
Doping

Important for CMOS, pn-junctions and good contacts. Substitutional doping is difficult without destroying CNTs.

CNTFETs in air

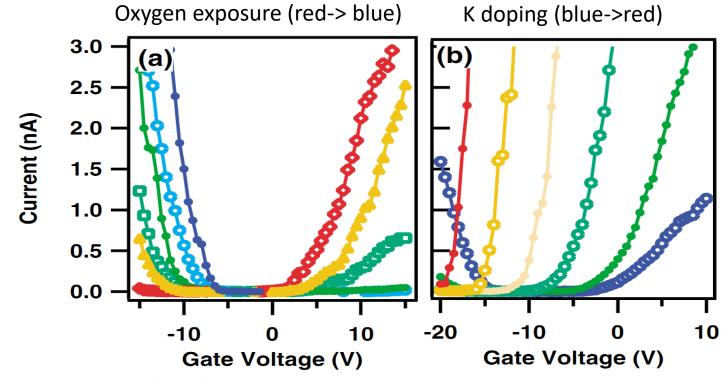
- Physisorbed oxygen p-dopes CNT
 OR
- Increases metal work function of contact





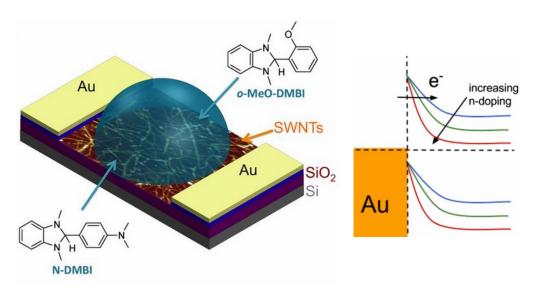
Potassium doping

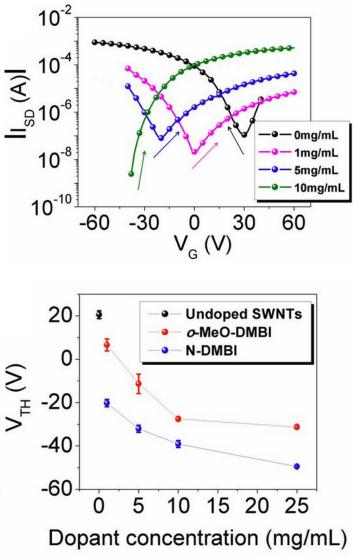
- O exposure -> p-branch is lowered, n-branch is increased, no V_{th} shift
- K physisorbed on CNT n-dopes by charge transfer -> V_{th} shift
- O: changes work function / K: dopes CNT



Doping of thin film CNTFETs

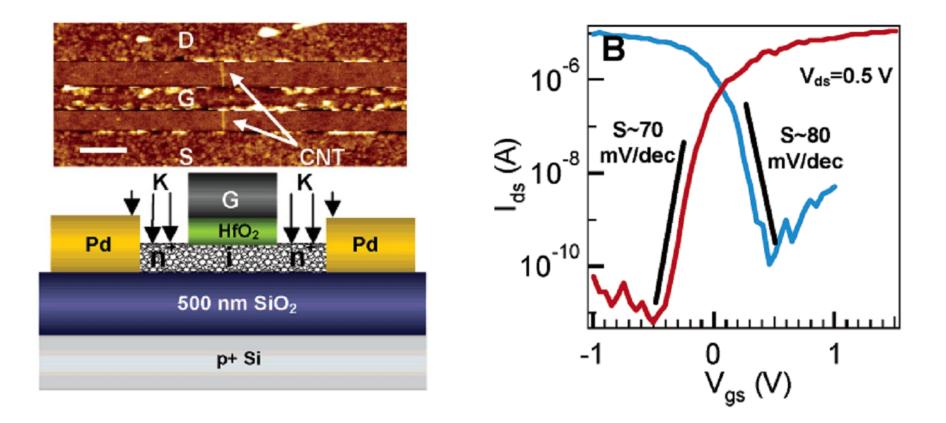
- Organic molecules are deposited on CNT network
- n-doping lower Schottky barrier for holes and shifts V_{th}





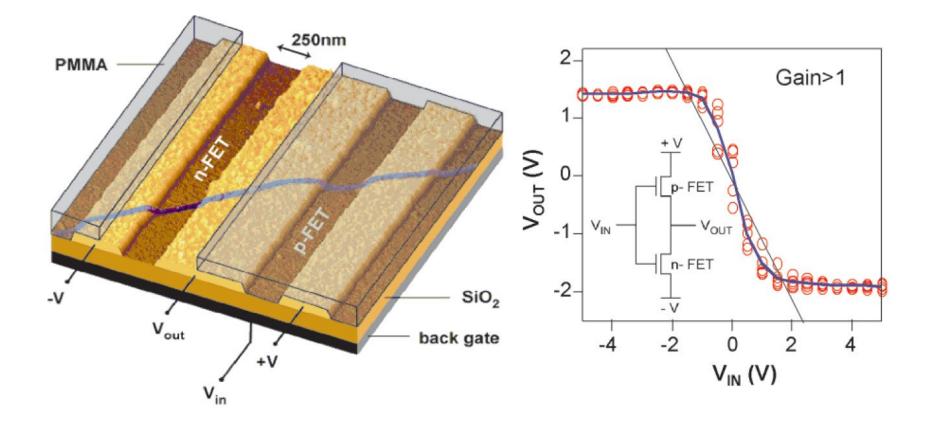
Doped contacts

- n dope outer CNT segments using K
- Removes influence from Schottky barrier at metal contact



Logic gates

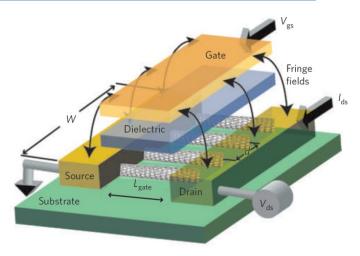
- Inverter from p and n CNTFET on the same CNT
- Use K doping or annealing to form n-CNTFET



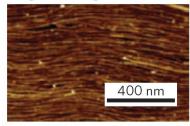
Derycke et al. Nano Lett. 1, 453-456 (2001)

Positioning

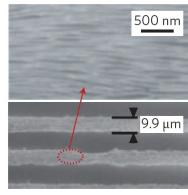
- Multiple parallell CNTs in each FET increases I_{on}, g_m
- Dense packing reduces parasitic capacitances
- Need to control position and orientation of CNTs pre- or postgrowth



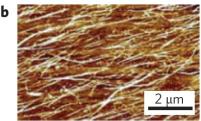
Langmuir-Blodgett



Droplet

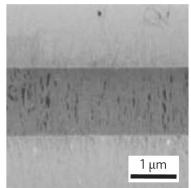


Spin-coating

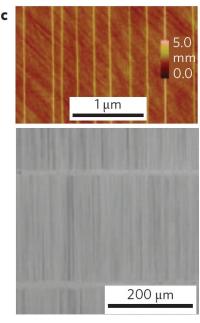


Dielectrophoresis

е

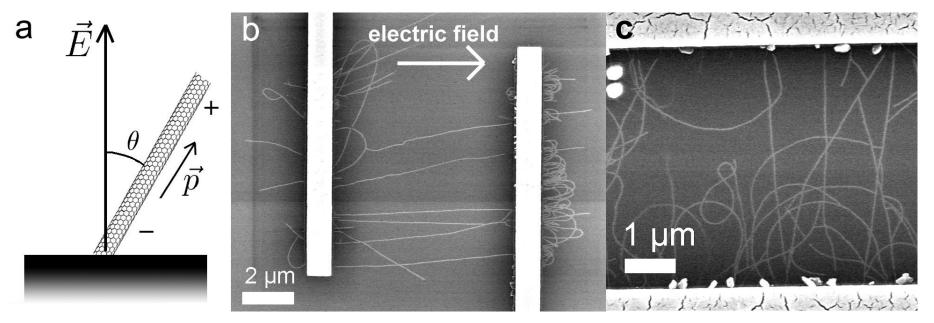


CVD



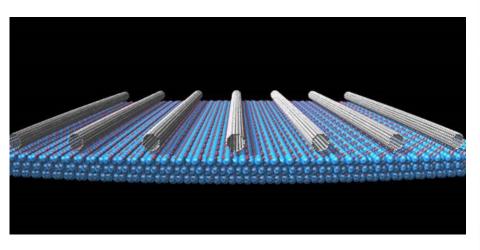
Electric field alignment

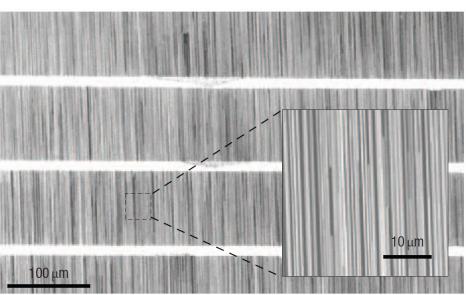
- Apply voltage to electrodes during CVD
- Dipole in CNTs align them with field lines
- Difficult to implement for large scale circuits



"epitaxial" alignment

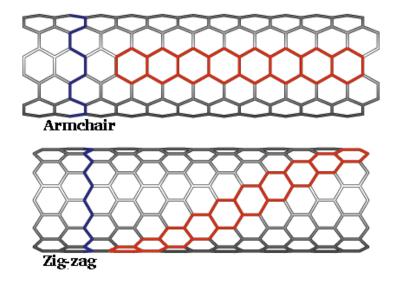
- CNTs align in certain crystal orientations of sapphire (Al₂O₃) or quartz substrates
- CNTs align at atomic steps
- Strong attractive interaction between CNTs and Al atoms
- 99.9% are aligned within 0.01°
- 10 CNTs / μm





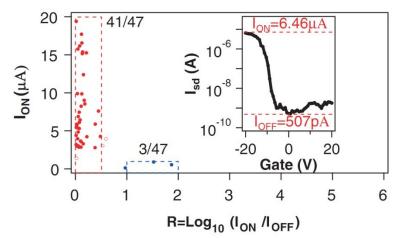
Chirality control

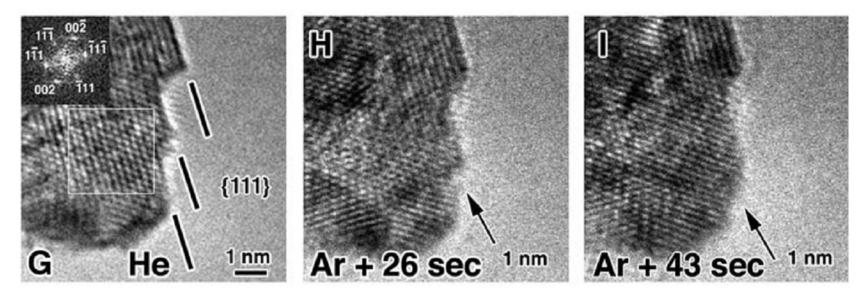
- Metallic CNTs in FETs -> leakage currents > poor on/off ratio
- Need chirality control or at least control of CNT type
- Need to either:
 - Selectively grow only metallic or semiconducting
 - Separate the two types
 - Selectively destroy one type



Selective growth

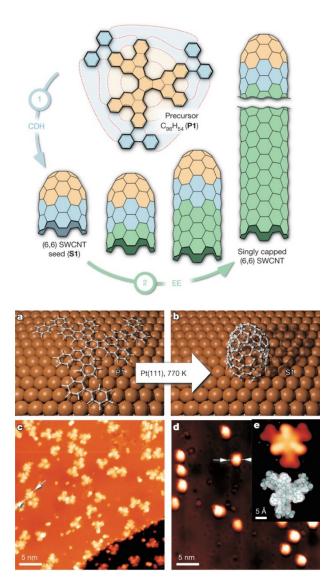
- Anneal metal catalyst in Ar, He or H₂
- Increased metallic CNT part from 33% to 91%
- Strong facets when annealed in He
- Steps in particle important for chirality control?
- Not well understood!



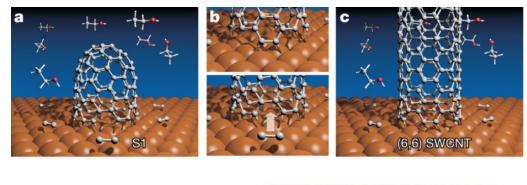


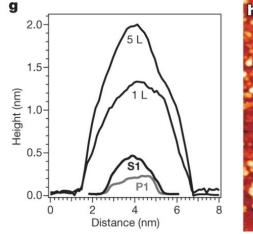
Harutyunyan et al. Science, 326, 116-120 (2009)

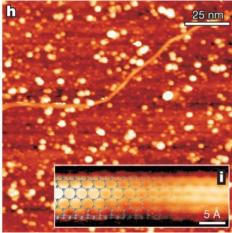
Templated growth



- Molecule defines cap
- Only (6,6) CNTs i.e. "real" metallic



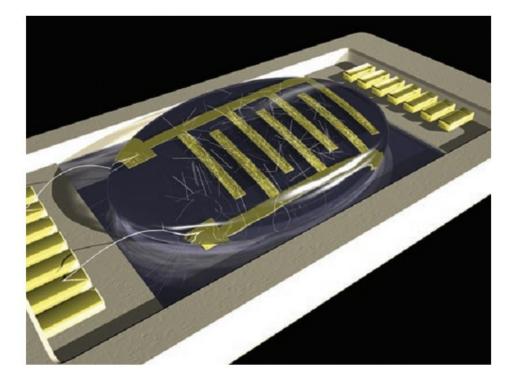


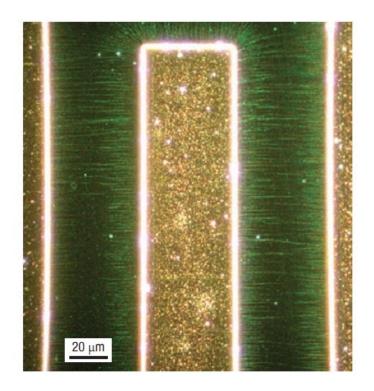


Sanchez-Valencia et al. Nature 512, 61–64 (2014)

Separation by dielectrophoresis

- AC voltage between electrodes
- Drop with CNTs
- Metallic CNTs attracted to electrodes and removed from suspension
- Only small scale (nanograms)

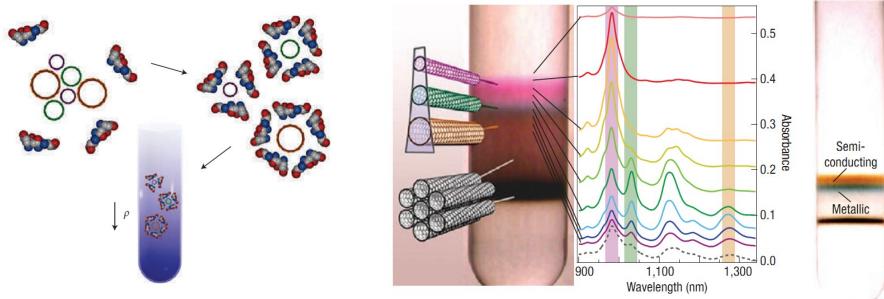




Separation by centrifugation

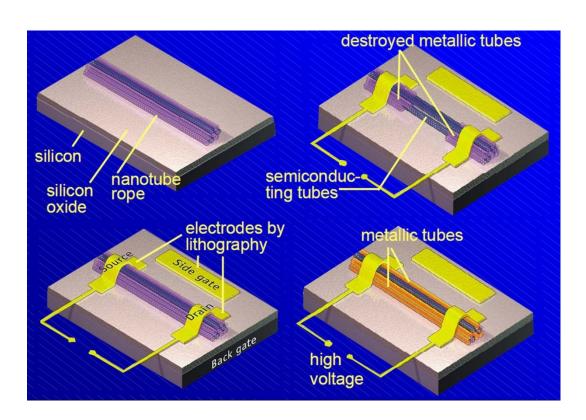
- Centrifuge CNT suspension at 64000 rpm -> 200000 g
- CNTs are sorted according to density
- Pick up some part of vial and repeat
- 97% of CNTs are within 0.2 Å of mean diameter

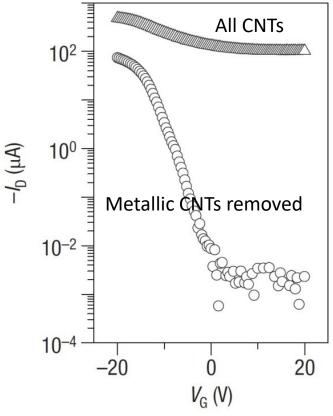




Selective destruction

- Apply gate voltage to switch off semiconducting CNTs
- Apply high S/D voltage
- Metallic CNTs are heated and destroyed
- Difficult for large scale circuits
- May destroy nearby CNTs



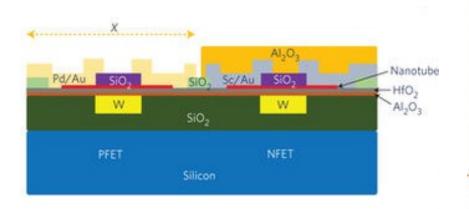


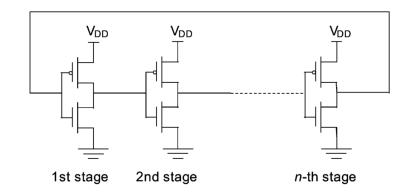
Outline

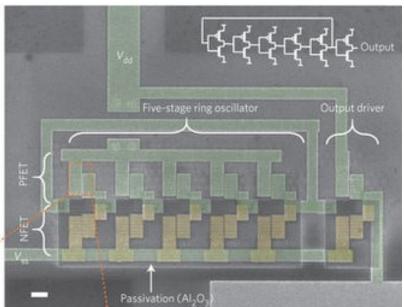
- Basics of graphene and CNTs
 - Structural
 - Electronic
 - Production of CNTs
- Advantages of CNTs for FETs
 - Electrostatics -> length scaling
 - High-k compatibility
 - Band-to-band tunneling
- Challenges of CNT integration
 - Contacts
 - Doping
 - Positioning
 - Chirality control
- Towards integration
 - Flexible electronics
 - High frequency performance

Ring Oscillator

- Odd number of inverters in series, output connected to input.
- Used to measure speed of digital technologies.
- Centrifuged NWs = 99.9% semiconducting
- Switching time = 355 ps /stage (2.8 Ghz)

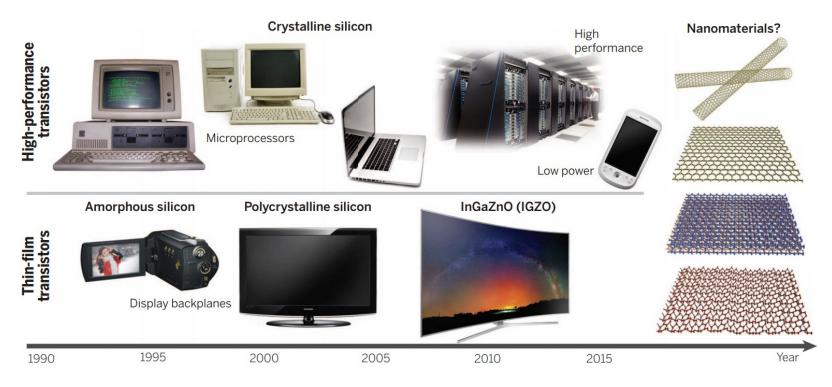






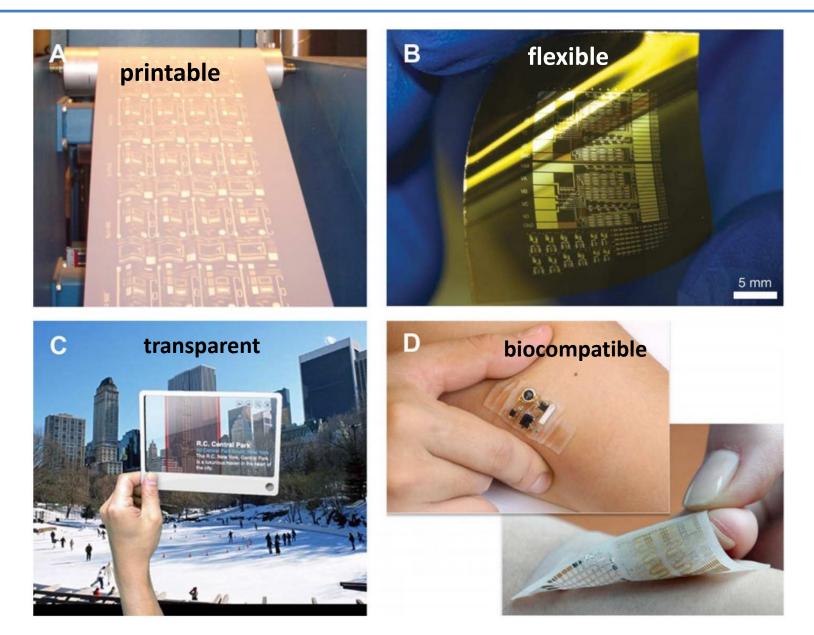
Thin film transistors

- Printed / flexible / transparent / biomedical electronics
- Lower requirements on size and speed
- More sensitive to cost and fabrication complexity
- Amorphous-Si, Poly-Si, InGaZnO, organic molecules



Franklin. Science, 349, 6249 (2015)

Thin film transistors



Flexible electronics

10³

- Graphene for electrodes
- **CNTs for channel**

(b) 10

10

10-10

20

15

8

Radius (mm)

ò

°01 °01 °01

No degradation when bent

(c)

60

40

20

Transconductance (nA/V)

Current (A)

10-7

10

10-9

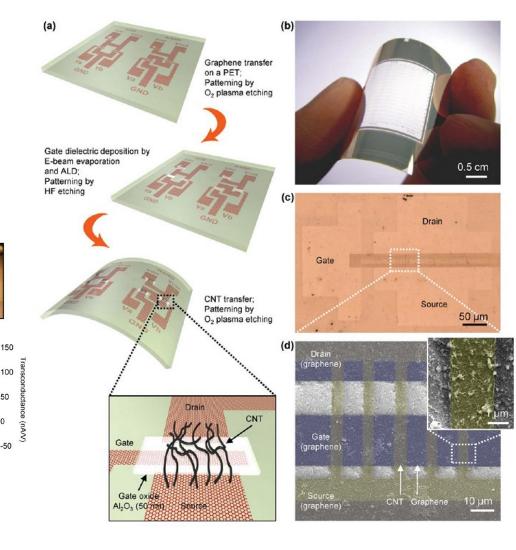
10

10⁰

10¹

Bending counts

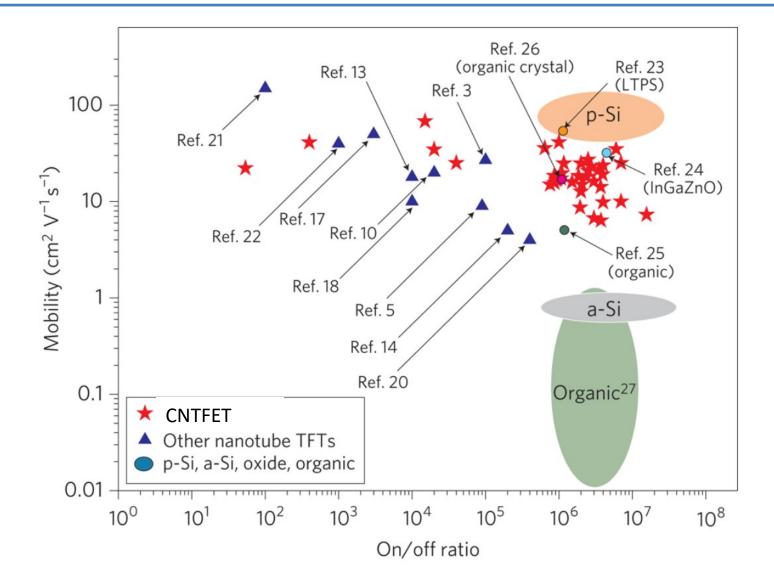
10²



ò

15 20

Thin film transistors comparison



Requirements for RF applications

/ ds

- Need high g_m and low g_d -> only semiconducting CNTs
- Minimize paracitic capacitance / CNT -> dense array of CNTs

$$f_{\rm T} = \frac{g_{\rm m}}{2\pi} \frac{1}{(C_{\rm gs} + C_{\rm p,gs} + C_{\rm p,gd})((R_{\rm p,s} + R_{\rm p,d})g_{\rm d} + 1) + C_{\rm p,gd}g_{\rm m}(R_{\rm p,s} + R_{\rm p,d})}$$

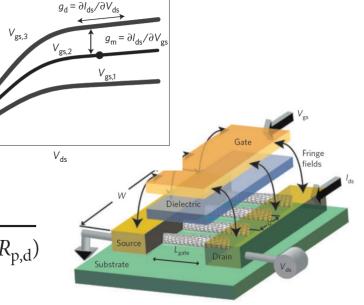


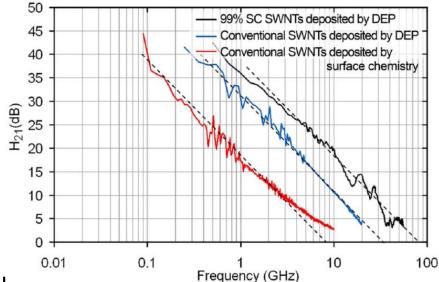
Table 1 | Ideal parameter values for making a high-frequency field-effect transistor from single-walled nanotubes.

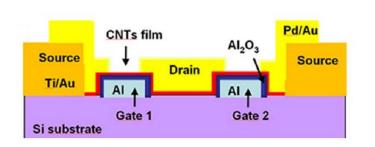
Property/parameter	Target value or range	Justification
Diameter	1.5–2.0 nm	Current is largest in this range ⁵⁴⁻⁵⁵ .
Chirality	Semiconducting and same (n,m)	To obtain identical transport properties.
Purity	>99% semiconducting nanotubes	No metallic nanotubes for high gain and high f_{max} .
Length	>1µm	Nanotube length must be longer than the intended channel length.
Density		Reduces the parasitic capacitance per nanotube; increases current carrying capacity; improves impedance matching.
Alignment	All parallel	Results in higher transconductance and denser nanotube packing.
Uniformity	Wafer scale	Essential for large-scale processing.

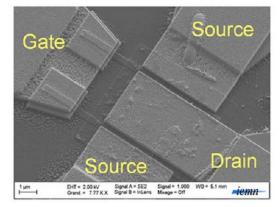
Rutherglen, Nature nanotechnol. 4, 811 (2009)

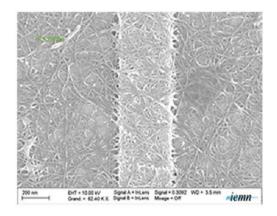
RF performance

- Can not use single CNT due large parasitic capacitance (and impedance mismatch)
- Use semiconducting CNTs separated using centrifugation
- $f_T = 80 \text{ GHz}$
- Much better than unseparated CNT material





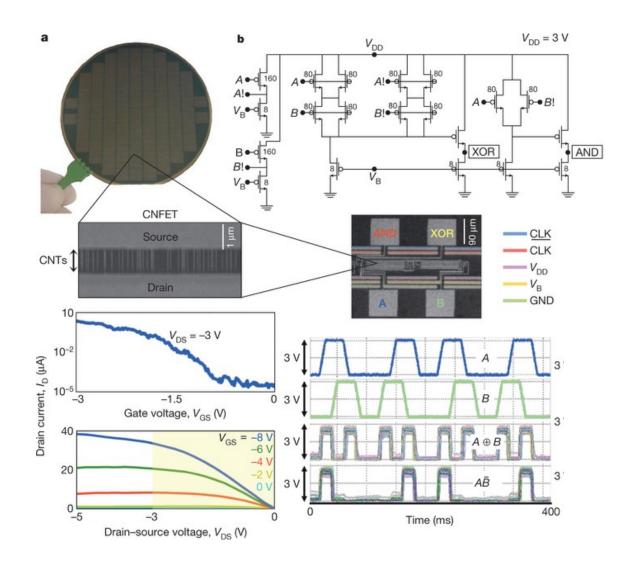




Nougaret et al. APL, 94, 243505 (2009)

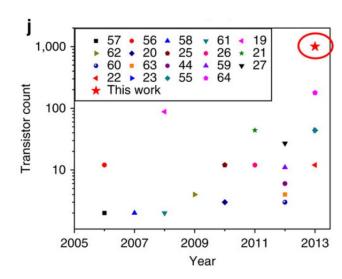
CNT computer

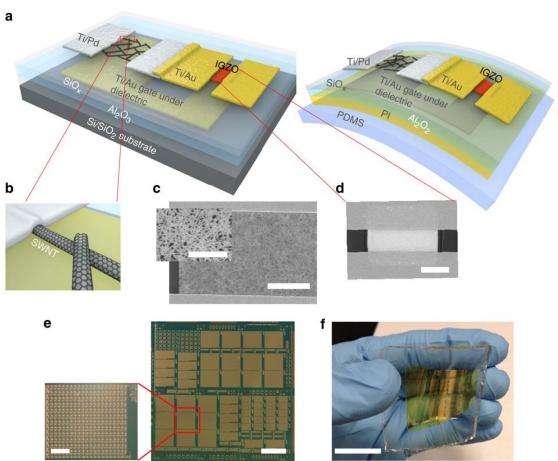
- 178 p-type CNTFETs.
 Aliged growth -> transfer
 -> burn-off
- Not CMOS, only p-type.
- Counting and number sorting.
- 1980's level.



Large scale integration

- p-type CNTFETs (from centrifuged CNTs)
- n-type InGaZnO (sputtered)
- Flexible substrate
- 501 stage ring oscillators
- >1000 transistors





Summary

- Individual CNTs have great electronic properties
 - High mobility
 - Coaxial gate + thin gives good electrostatics -> scaling
 - Compatible with high-k dielectrics
 - No surface scattering
- CNTs are difficult to integrate in large scale circuits
 - Schottky barriers at contacts
 - Unstable doping
 - Poor position control
 - Semiconducting / metallic mix